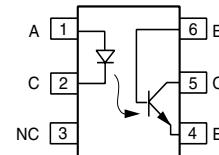
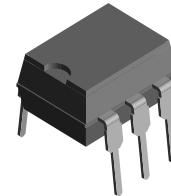


## 4N25/ 4N26/ 4N27/ 4N28

## Optocoupler, Phototransistor Output, With Base Connection

**Features**

- Isolation Test Voltage 5300 V<sub>RMS</sub>
- Interfaces with Common Logic Families
- Input-output Coupling Capacitance < 0.5 pF
- Industry Standard Dual-in-line 6-pin Package
- Lead-free component
- Component in accordance to RoHS 2002/95/EC and WEEE 2002/96/EC

**Agency Approvals**

- UL1577, File No. E52744 System Code H or J, Double Protection
- DIN EN 60747-5-2 (VDE0884)  
DIN EN 60747-5-5 pending  
Available with Option 1

**Applications**

AC Mains Detection  
Reed relay driving  
Switch Mode Power Supply Feedback  
Telephone Ring Detection  
Logic Ground Isolation  
Logic Coupling with High Frequency Noise Rejection

**Description**

The 4N25 family is an Industry Standard Single Channel Phototransistor Coupler. This family includes the 4N25/ 4N26/ 4N27/ 4N28. Each optocoupler consists of gallium arsenide infrared LED and a silicon NPN phototransistor.

These couplers are Underwriters Laboratories (UL) listed to comply with a 5300 V<sub>RMS</sub> isolation test voltage. This isolation performance is accomplished through special Vishay manufacturing process.

Compliance to DIN EN 60747-5-2(VDE0884)/ DIN EN 60747-5-5 pending partial discharge isolation specification is available by ordering option1.

These isolation processes and the Vishay ISO9001 quality program results in the highest isolation performance available for a commercial plastic phototransistor optocoupler.

The devices are also available in lead formed configuration suitable for surface mounting and are available either on tape and reel, or in standard tube shipping containers.

## Note:

For additional design information see Application Note 45 Normalized Curves

**Order Information**

Part	Remarks
4N25	CTR > 20 %, DIP-6
4N26	CTR > 20 %, DIP-6
4N27	CTR > 10 %, DIP-6
4N28	CTR > 10 %, DIP-6
4N25-X006	CTR > 20 %, DIP-6 400 mil (option 6)
4N25-X007	CTR > 20 %, SMD-6 (option 7)
4N25-X009	CTR > 20 %, SMD-6 (option 9)
4N26-X006	CTR > 20 %, DIP-6 400 mil (option 6)
4N26-X007	CTR > 20 %, SMD-6 (option 7)
4N26-X009	CTR > 20 %, SMD-6 (option 9)
4N27-X007	CTR > 10 %, SMD-6 (option 7)
4N27-X009	CTR > 10 %, SMD-6 (option 9)
4N28-X009	CTR > 10 %, SMD-6 (option 9)

For additional information on the available options refer to Option Information.

# 4N25/ 4N26/ 4N27/ 4N28



## Absolute Maximum Ratings

$T_{amb} = 25 \text{ }^{\circ}\text{C}$ , unless otherwise specified

Stresses in excess of the absolute Maximum Ratings can cause permanent damage to the device. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. Exposure to absolute Maximum Rating for extended periods of the time can adversely affect reliability.

## Input

Parameter	Test condition	Symbol	Value	Unit
Reverse voltage		$V_R$	6.0	V
Forward current		$I_F$	60	mA
Surge current	$t < 10 \mu\text{s}$	$I_{FSM}$	2.5	A
Power dissipation		$P_{diss}$	100	mW

## Output

Parameter	Test condition	Symbol	Value	Unit
Collector-emitter breakdown voltage		$V_{CEO}$	70	V
Emitter-base breakdown voltage		$V_{EBO}$	7.0	V
Collector current		$I_C$	50	mA
Collector currrent	$t < 1.0 \text{ ms}$	$I_C$	100	mA
Power dissipation		$P_{diss}$	150	mW

## Coupler

Parameter	Test condition	Symbol	Value	Unit
Isolation test voltage		$V_{ISO}$	5300	$V_{RMS}$
Creepage			$\geq 7.0$	mm
Clearance			$\geq 7.0$	mm
Isolation thickness between emitter and detector			$\geq 0.4$	mm
Comparative tracking index	DIN IEC 112/VDE0303, part 1		175	
Isolation resistance	$V_{IO} = 500 \text{ V}, T_{amb} = 25 \text{ }^{\circ}\text{C}$	$R_{IO}$	$10^{12}$	$\Omega$
	$V_{IO} = 500 \text{ V}, T_{amb} = 100 \text{ }^{\circ}\text{C}$	$R_{IO}$	$10^{11}$	$\Omega$
Storage temperature		$T_{stg}$	- 55 to + 150	$^{\circ}\text{C}$
Operating temperature		$T_{amb}$	- 55 to + 100	$^{\circ}\text{C}$
Junction temperature		$T_j$	100	$^{\circ}\text{C}$
Soldering temperature	max.10 s, dip soldering: distance to seating plane $\geq 1.5 \text{ mm}$	$T_{sld}$	260	$^{\circ}\text{C}$

## Electrical Characteristics

$T_{amb} = 25^{\circ}\text{C}$ , unless otherwise specified

Minimum and maximum values are testing requirements. Typical values are characteristics of the device and are the result of engineering evaluation. Typical values are for information only and are not part of the testing requirements.

## Input

Parameter	Test condition	Symbol	Min	Typ.	Max	Unit
Forward voltage <sup>1)</sup>	$I_F = 50 \text{ mA}$	$V_F$		1.3	1.5	V
Reverse current <sup>1)</sup>	$V_R = 3.0 \text{ V}$	$I_R$		0.1	100	$\mu\text{A}$
Capacitance	$V_R = 0 \text{ V}$	$C_O$		25		pF

<sup>1)</sup> Indicates JEDEC registered values

## Output

Parameter	Test condition	Part	Symbol	Min	Typ.	Max	Unit
Collector-base breakdown voltage <sup>1)</sup>	$I_C = 100 \mu\text{A}$		$BV_{CBO}$	70			V
Collector-emitter breakdown voltage <sup>1)</sup>	$I_C = 1.0 \text{ mA}$		$BV_{CEO}$	30			V
Emitter-collector breakdown voltage <sup>1)</sup>	$I_E = 100 \mu\text{A}$		$BV_{ECO}$	7.0			V
$I_{CEO}(\text{dark})^1)$	$V_{CE} = 10 \text{ V}, (\text{base open})$	4N25			5.0	50	nA
		4N26			5.0	50	nA
		4N27			5.0	50	nA
		4N28			10	100	nA
$I_{CBO}(\text{dark})^1)$	$V_{CB} = 10 \text{ V}, (\text{emitter open})$				2.0	20	nA
Collector-emitter capacitance	$V_{CE} = 0$		$C_{CE}$		6.0		pF

<sup>1)</sup> Indicates JEDEC registered values

## Coupler

Parameter	Test condition	Part	Symbol	Min	Typ.	Max	Unit
Isolation voltage <sup>1)</sup>	Peak, 60 Hz	4N25	$V_{IO}$	2500			V
		4N26	$V_{IO}$	1500			V
		4N27	$V_{IO}$	1500			V
		4N28	$V_{IO}$	500			V
Saturation voltage, collector-emitter	$I_{CE} = 2.0 \text{ mA}, I_F = 50 \text{ mA}$		$V_{CE(\text{sat})}$			0.5	V
Resistance, input output <sup>1)</sup>	$V_{IO} = 500 \text{ V}$		$R_{IO}$	100			$\text{G}\Omega$
Capacitance (input-output)	$f = 1.0 \text{ MHz}$		$C_{IO}$		0.5		pF

<sup>1)</sup> Indicates JEDEC registered values

## Current Transfer Ratio

Parameter	Test condition	Part	Symbol	Min	Typ.	Max	Unit
DC Current Transfer Ratio <sup>1)</sup>	$V_{CE} = 10 \text{ V}, I_F = 10 \text{ mA}$	4N25	$CTR_{DC}$	20	50		%
		4N26	$CTR_{DC}$	20	50		%
		4N27	$CTR_{DC}$	10	30		%
		4N28	$CTR_{DC}$	10	30		%

<sup>1)</sup> Indicates JEDEC registered value

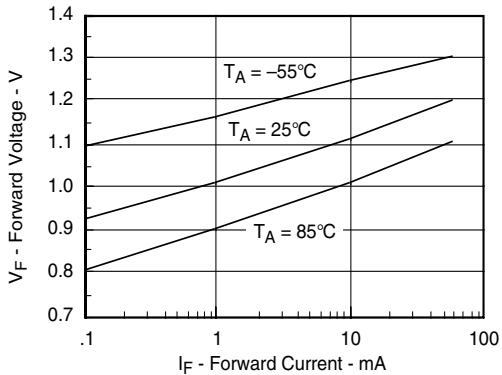
# 4N25/ 4N26/ 4N27/ 4N28

## Switching

### Characteristics

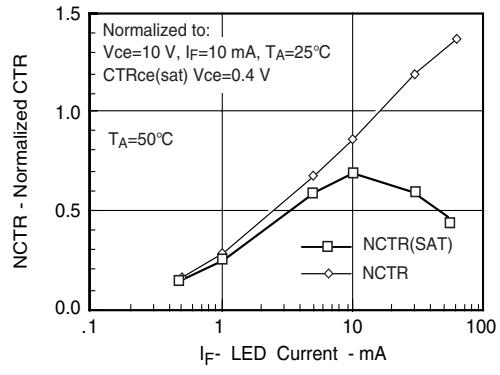
Parameter	Test condition	Symbol	Min	Typ.	Max	Unit
Rise and fall times	$V_{CE} = 10 \text{ V}$ , $I_F = 10 \text{ mA}$ , $R_L = 100 \Omega$	$t_r, t_f$		2.0		$\mu\text{s}$

### Typical Characteristics (Tamb = 25 °C unless otherwise specified)



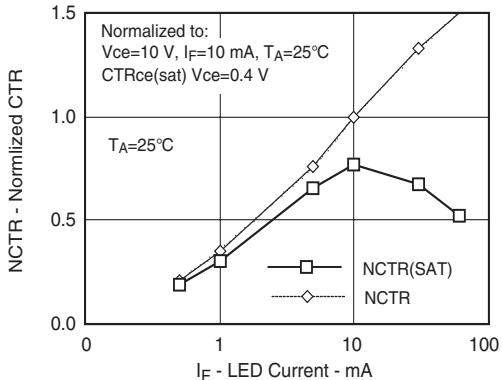
i4n25\_01

Figure 1. Forward Voltage vs. Forward Current



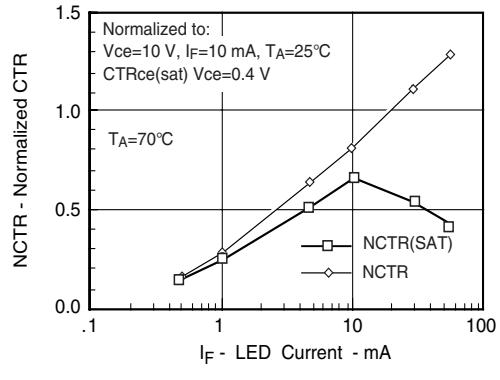
i4n25\_03

Figure 3. Normalized Non-saturated and Saturated CTR vs. LED Current



i4n25\_02

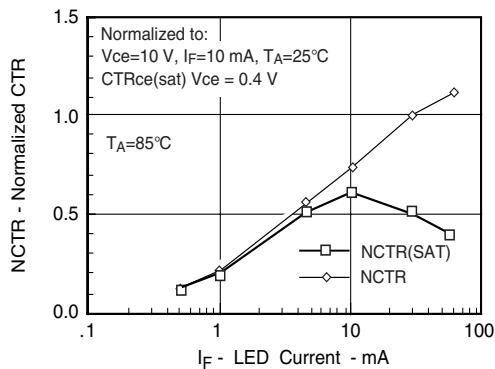
Figure 2. Normalized Non-Saturated and Saturated CTR vs. LED Current



i4n25\_04

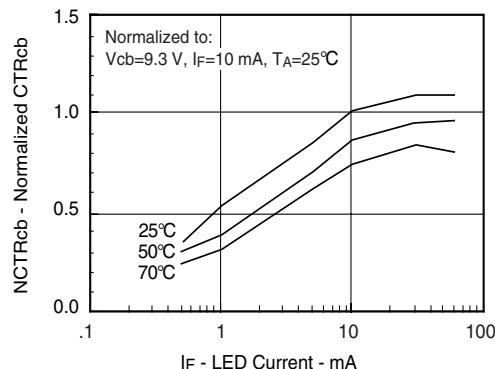
Figure 4. Normalized Non-saturated and saturated CTR vs. LED Current

# 4N25/ 4N26/ 4N27/ 4N28



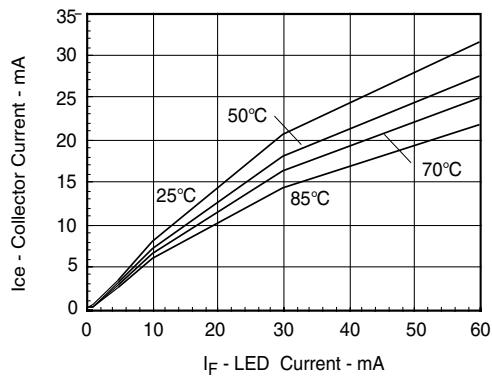
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Figure 5. Normalized Non-saturated and saturated CTR vs. LED Current



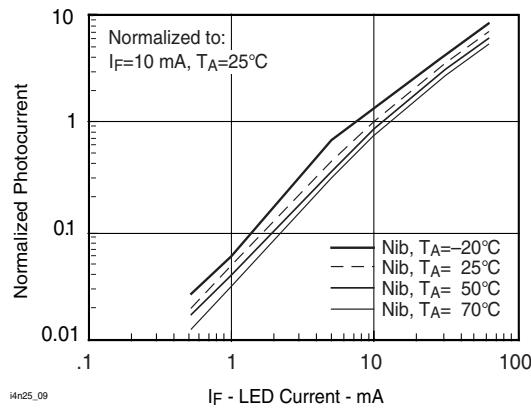
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Figure 8. Normalized CTRcb vs. LED Current and Temp.



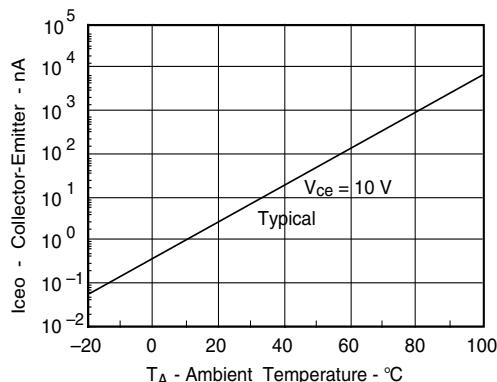
i4n25\_06

Figure 6. Collector-Emitter Current vs. Temperature and LED Current



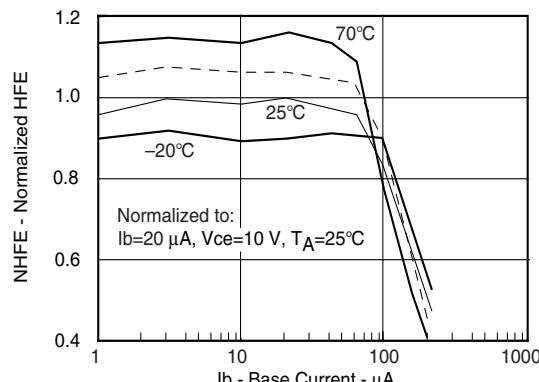
i4n25\_09

Figure 9. Normalized Photocurrent vs.  $I_F$  and Temp.



i4n25\_07

Figure 7. Collector-Emitter Leakage Current vs.Temp.

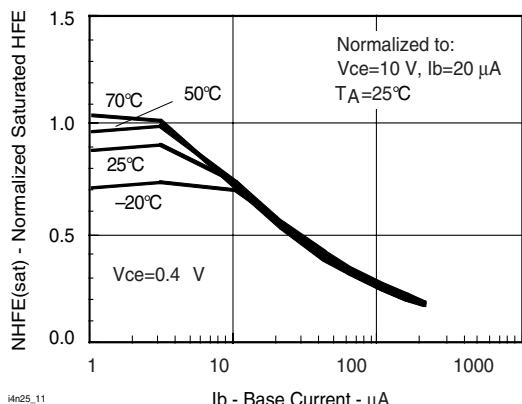


i4n25\_10

Figure 10. Normalized Non-saturated HFE vs. Base Current and Temperature

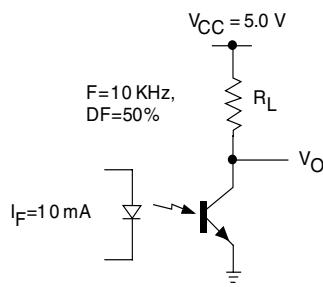
# 4N25/ 4N26/ 4N27/ 4N28

Vishay Semiconductors



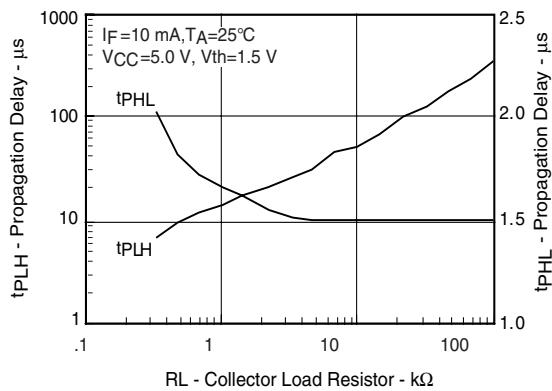
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Figure 11. Normalized HFE vs. Base Current and Temp.



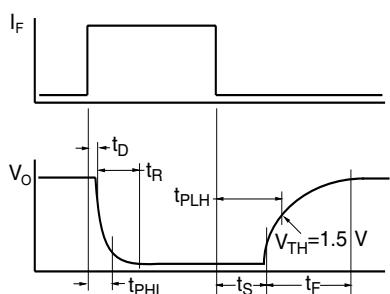
i4n25\_14

Figure 14. Switching Schematic



i4n25\_12

Figure 12. Propagation Delay vs. Collector Load Resistor



i4n25\_13

Figure 13. Switching Timing

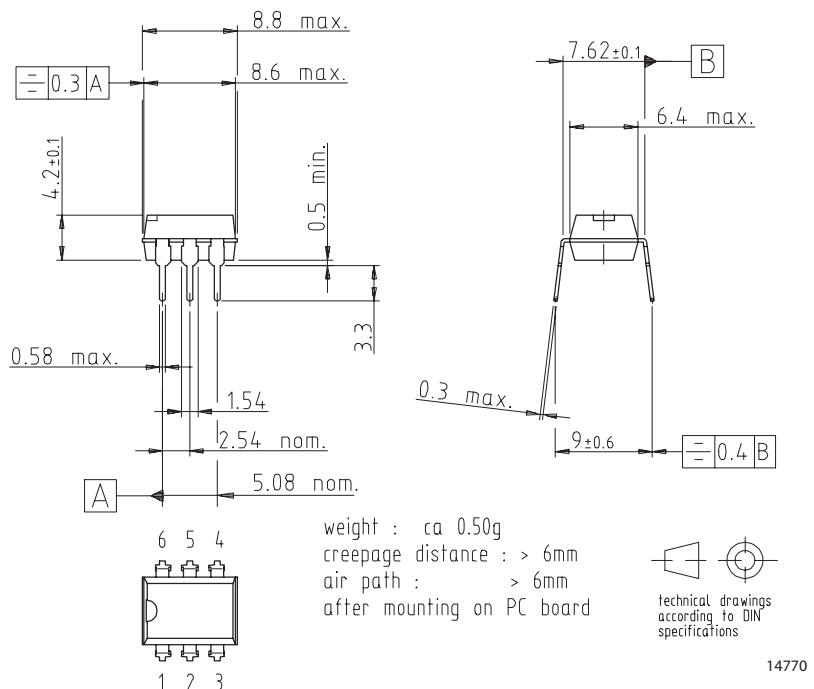
# 4N25/ 4N26/ 4N27/ 4N28

## Package Dimensions in Inches (mm)

For 4N25/26/27..... see DIL300-6 Package dimension in the Package Section.

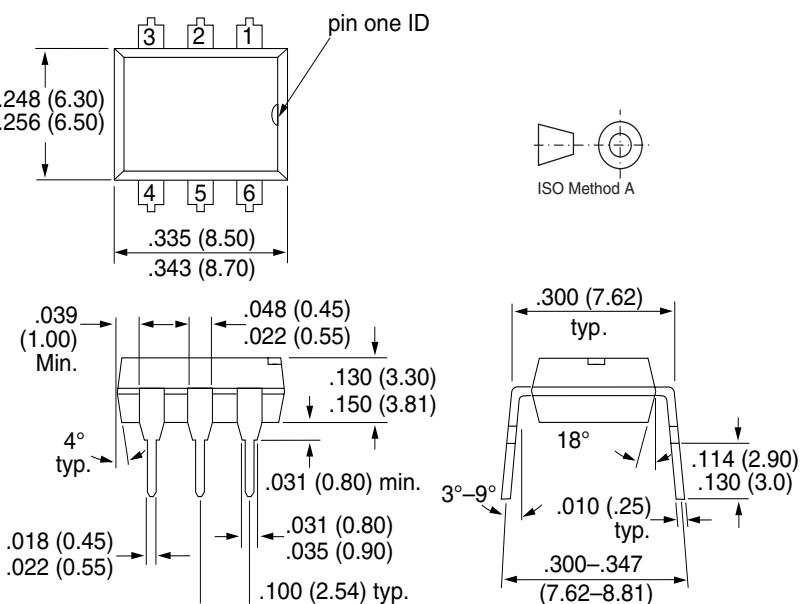
For 4N28 and for products with an option designator (e.g. 4N25-X001 or 4N26-X007).... see DIP-6 Package dimensions in the Package Section.

### DIL300-6 Package Dimensions



14770

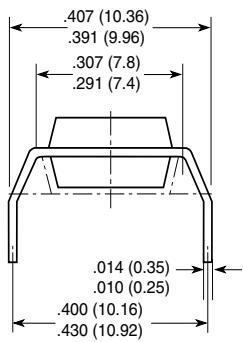
### DIP-6 Package Dimensions



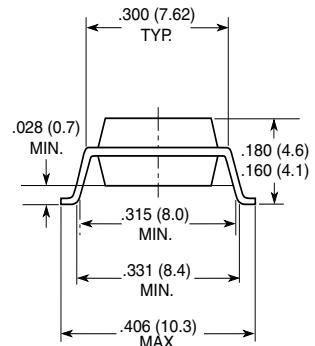
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# 4N25/ 4N26/ 4N27/ 4N28

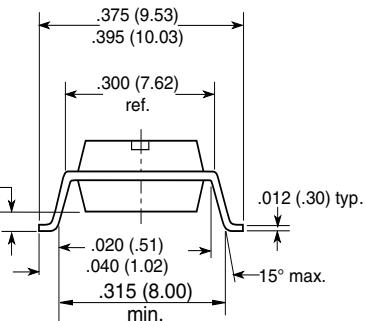
Option 6



Option 7



Option 9



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